Notice of References Cited

Application/Control No. 10/566,108	Reexaminatio	Applicant(s)/Patent Under Reexamination MORITA ET AL.		
Examiner	Art Unit			
Bobbak Safainour	2618	Page 1 of 2		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	, Classification
*	Α	US-2002/0024937 A1	02-2002	Barnard et al.	370/278
*	В	US-6,353,602 B1	03-2002	Cheng et al.	370/332
*	C.	US-2002/0032034 A1	03-2002	Tiedemann et al.	455/437
*	D	US-2003/0003951 A1	01-2003	Leprieur et al.	455/552
*	Е	US-2003/0129992 A1	07-2003	Koorapaty et al.	455/456
*	F	US-2004/0048612 A1	03-2004	Virtanen et al.	455/426.1
*	G	US-2004/0100913 A1	05-2004	Kalliokulju et al.	370/252
*	Н	US-6,975,881 B2	12-2005	Sheynman et al.	455/552.1
*	1	US-6,987,985,B2	01-2006	Purkayastha et al.	455/552.1
*	J	US-2006/0058041 A1	03-2006	Cheng, Steven D.	455/456.3
*	К	US-7,047,036 B2	05-2006	Shaheen et al.	455/552.1
*	L	US-7,054,634 B2	05-2006	Watanabe et al.	455/440
*	М	US-2006/0211447 A1	09-2006	Purkayastha et al.	455/552.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	·				
	S					:
	Т			, , , , , , , , , , , , , , , , , , , ,		

NON-PATENT DOCUMENTS

_	NON-FATENT DOCUMENTS					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ					
		*				
	0 17					
	V					
	w					
	×					

*A copy of this reference is not being furnis hed with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.

Notice of References Cited Application/Control No. 10/566,108 Applicant(s)/Patent Under Reexamination MORITA ET AL. Examiner Art Unit Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0148771 A1	08-2003	de Verteuil, Andre Laurent	455/456
*	В	US-2004/0196807 A1 -	10-2004	Shiraga, Kazuhiro	370/329
*	С	US-2004/0224719 A1	11-2004	Nounin et al.	455/553.1
*	D	US-2004/0259573 A1	12-2004	Cheng, Steven D.	455/456.3
*	Е	US-2005/0009499 A1	01-2005	Koster, Karl	455/406
*	F	US-2005/0037734 A1	02-2005	Tanaka et al.	455/411
*	G	US-2005/0255880 A1	11-2005	Inoue, Atsushi	455/552.1
*	Н	US-2004/0264410 a1	12-2004	Sagi et al.	370/331
	1	US-			
	J	US-			
	К	US-			
	L	US-	*		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					·
	0					
	Р			·		
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NOIS ATENT BOODINENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	٧					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classif ications may be US or foreign.